

Notice of References Cited	Application/Control No. 10/757,192	Applicant(s)/Patent Under Reexamination DEWITT ET AL.	
	Examiner Raymond Phan	Art Unit 2111	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,775,728	08-2004	Zimmer et al.	710/260
*	C	US-6,757,771	06-2004	Christie, David S.	710/260
*	D	US-6,148,321	11-2000	Hammond, Gary N.	718/100
*	E	US-6,275,893	08-2001	Bonola, Thomas J.	710/262
*	F	US-4,825,359	04-1989	Ohkami et al.	712/15
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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